

## Product Summary

$V_{(BR)DSS}$	$R_{DS(on)TYP}$	$I_D$
40V	0.75mΩ@10V	200A
	1.2mΩ@4.5V	

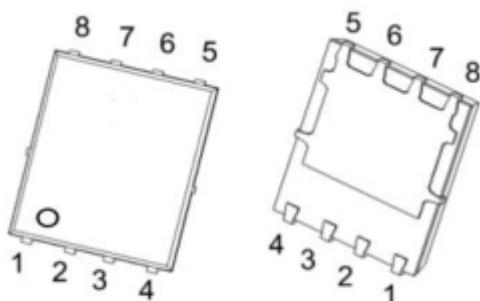
## Feature

- Fast Switching
- Low Gate Charge and Rdson
- Advanced Split Gate Trench Technology
- 100% Single Pulse avalanche energy Test

## Application

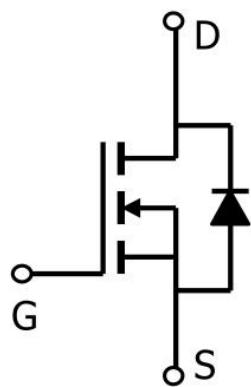
- PWM Application
- Hard switched and high frequency circuits
- Power Management

## Package



**PDFNWB5X6-8L**

## Circuit diagram



## Marking



**40N01G**      =Device Code  
**P**                =Clip Process  
**\***                =Month Code

## Absolute maximum ratings

( $T_a=25^\circ\text{C}$  unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	$V_{DS}$	40	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current( $T_c=25^\circ\text{C}$ )	$I_D$	200	A
Pulsed Drain Current	$I_{DM}$	800	A
Single Pulse Avalanche Energy <sup>1</sup>	$E_{AS}$	420	mJ
Avalanche Current	$I_{AS}$	41	A
Total Power Dissipation <sup>2</sup> ( $T_c=25^\circ\text{C}$ )	$P_D$	180	W
Thermal Resistance Junction-Case	$R_{\theta JC}$	0.67	$^\circ\text{C}/\text{W}$
Storage Temperature Range	$T_{STG}$	-55 to 150	$^\circ\text{C}$
Operating Junction Temperature Range	$T_J$	-55 to 150	$^\circ\text{C}$

## Electrical characteristics

( $T_A=25^\circ\text{C}$ , unless otherwise noted)

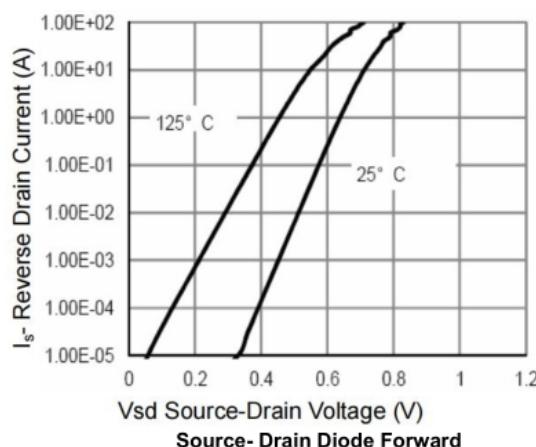
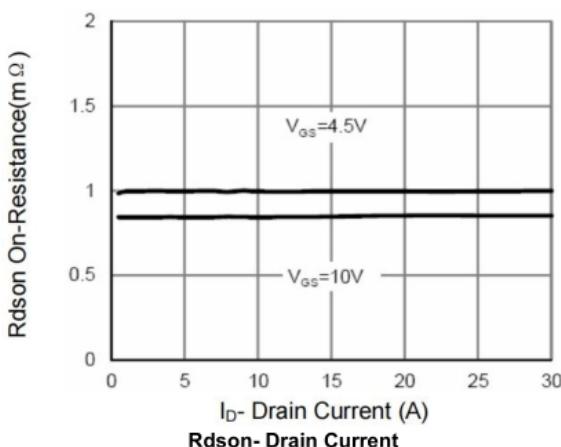
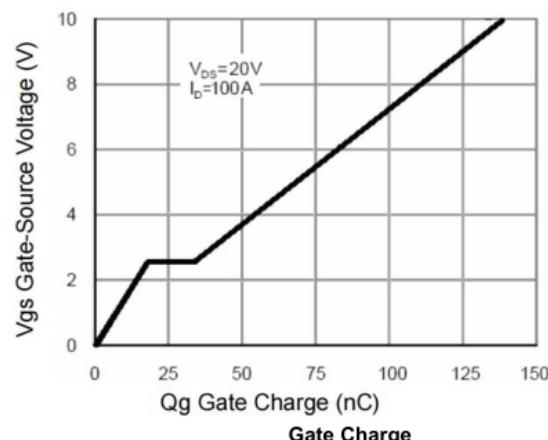
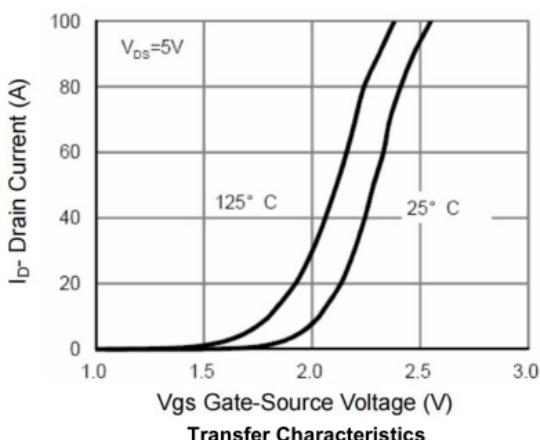
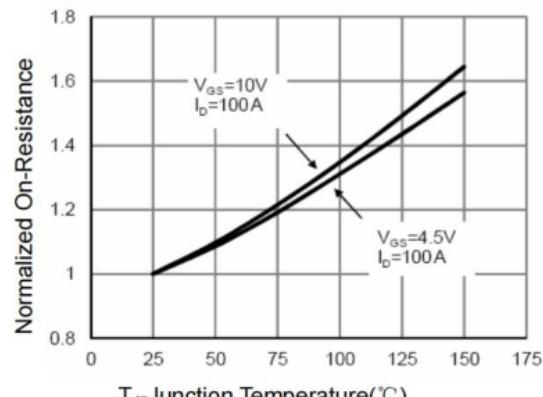
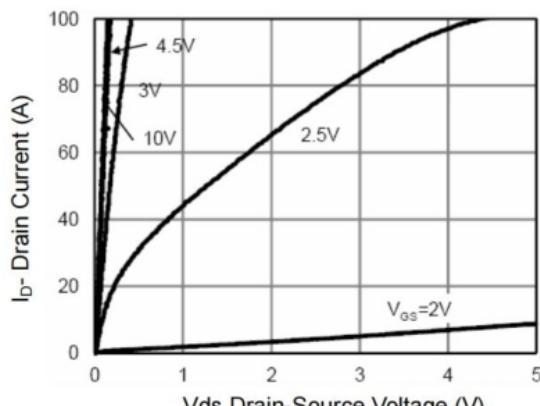
Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
<b>Static Characteristics</b>						
Drain-source breakdown voltage	$\text{BV}_{(\text{BR})\text{DSS}}$	$V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$	40			V
Drain-Source Leakage Current	$I_{DSS}$	$V_{DS} = 32\text{V}, V_{GS} = 0\text{V}, T_J = 25^\circ\text{C}$			1	$\mu\text{A}$
Gate-body leakage current	$I_{GSS}$	$V_{GS} = \pm 20\text{V}, V_{DS} = 0\text{V}$			$\pm 100$	$\mu\text{A}$
Gate-source threshold voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	1	1.6	2.5	V
Static Drain-Source On-Resistance	$R_{DS(\text{on})}$	$V_{GS} = 10\text{V}, I_D = 30\text{A}$		0.75	1.1	$\text{m}\Omega$
		$V_{GS} = 4.5\text{V}, I_D = 20\text{A}$		1.2	1.8	
<b>Dynamic Characteristics</b>						
Input Capacitance	$C_{iss}$	$V_{DS} = 20\text{V}, V_{GS} = 0\text{V}, f = 1\text{MHz}$		7515		$\text{pF}$
Output Capacitance	$C_{oss}$			1854		
Reverse Transfer Capacitance	$C_{rss}$			122		
<b>Switching Characteristics</b>						
Total Gate Charge	$Q_g$	$V_{DS} = 20\text{V}, V_{GS} = 10\text{V}, I_D = 85\text{A}$		128		$\text{pF}$
Gate-Source Charge	$Q_{gs}$			19		
Gate-Drain Charge	$Q_{gd}$			12		
Turn-On Delay Time	$T_{d(on)}$	$V_{DD} = 20\text{V}, V_{GS} = 10\text{V}, R_G = 1.6\Omega, I_D = 85\text{A}$		13.5		$\text{nS}$
Rise Time	$T_r$			8.8		
Turn-Off Delay Time	$T_{d(off)}$			52		
Fall Time	$T_f$			9.6		
<b>Diode Characteristics</b>						
Diode Forward Voltage <sup>2</sup>	$V_{SD}$	$V_{GS} = 0\text{V}, I_S = 1\text{A}, T_J = 25^\circ\text{C}$			1.2	V

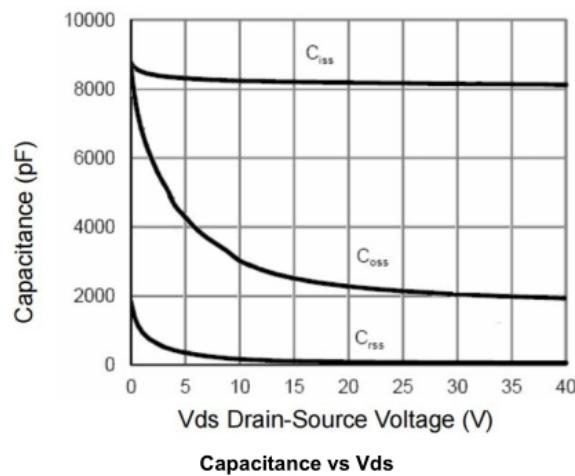
### Note:

1. The EAS data shows Max. rating . The test condition is  $V_{DD}=20\text{V}, V_{GS}=10\text{V}, L=0.5\text{mH}, R_G=25\Omega$

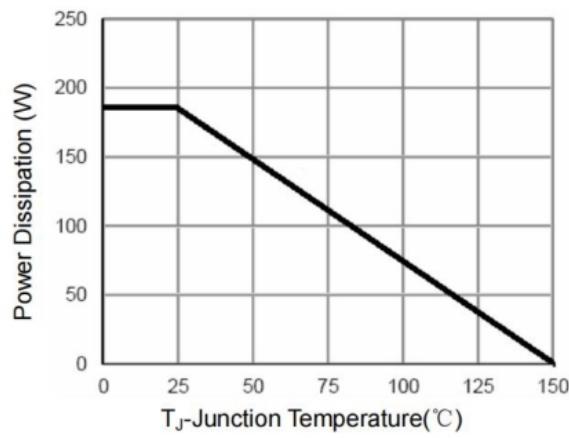
2. The power dissipation is limited by  $150^\circ\text{C}$  junction temperature

## Typical Characteristics

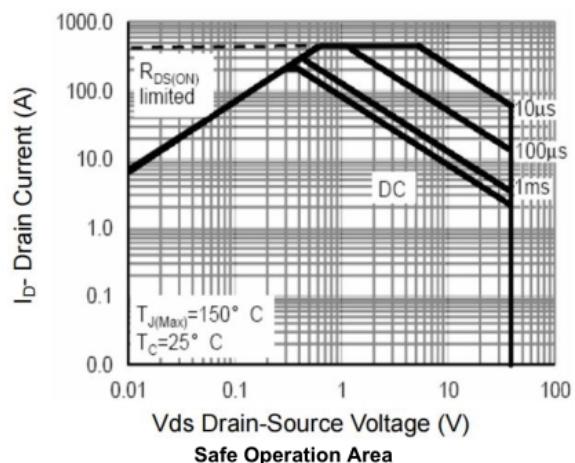




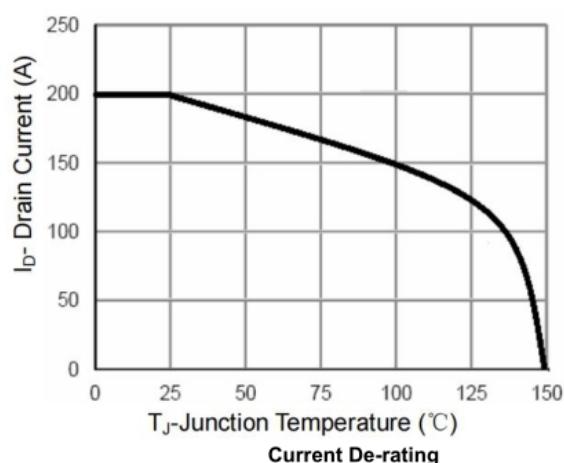
Capacitance vs Vds



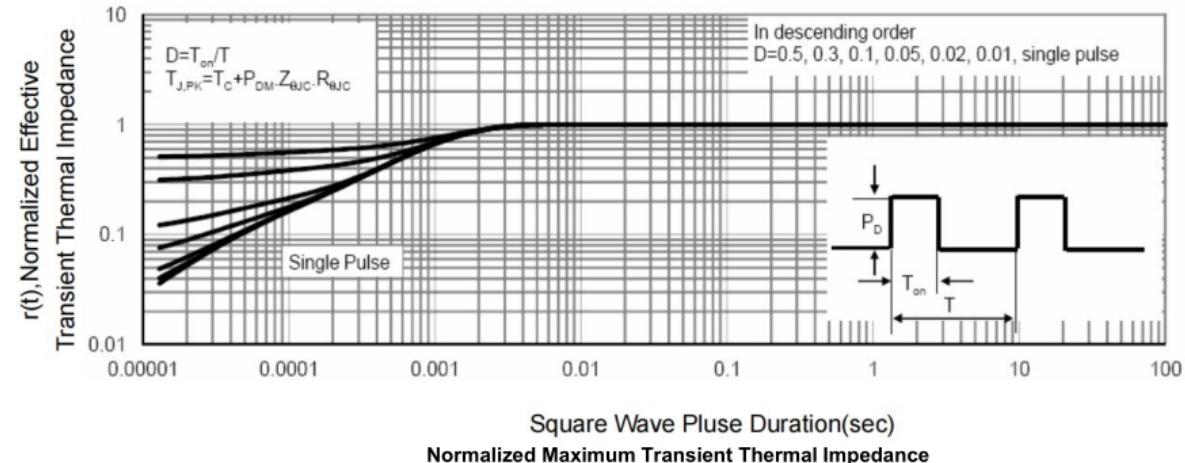
Power De-rating



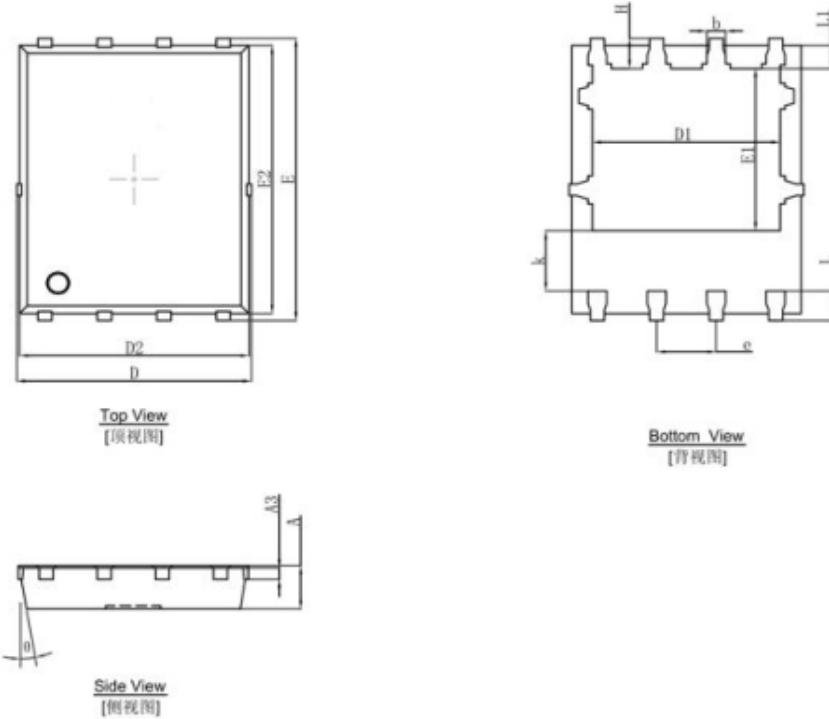
Safe Operation Area



Current De-rating



## PDFNWB5X6-8L Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.900	1.000	0.035	0.039
A3	0.254REF.		0.010REF.	
D	4.944	5.096	0.195	0.201
E	5.974	6.126	0.235	0.241
D1	3.910	4.110	0.154	0.162
E1	3.375	3.575	0.133	0.141
D2	4.824	4.976	0.190	0.196
E2	5.674	5.826	0.223	0.229
k	1.190	1.390	0.047	0.055
b	0.350	0.450	0.014	0.018
e	1.270TYP.		0.050TYP.	
L	0.559	0.711	0.022	0.028
L1	0.424	0.576	0.017	0.023
H	0.574	0.726	0.023	0.029
θ	10°	12°	10°	12°